

IN3170 V24 - Lab 3

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1 Introduction

2 Theory

2.1

3 Materials and Methods

3.1 Equipment

Component	Model	Quantity
Resistor	100k Ω	1
Capacitor	1 μ F	1
IC with 6 transistors	CD4007UBE	1
Copper wires	-	12
Printed Circuit Board	-	1
Soldering iron	-	1
Soldering wire	-	1
Oscilloscope	HP54622	1
Waveform generator	HP33120	1
Voltage source	HPE3631	1
Computer w/ "Cadence Virtuoso"	6.1.7	1
NMOSFET*	TSMC 65nm	3
Waveform generator*	-	2
Capacitor*	-	2

Table 1: List of components used in the experiment. Components marked with * are simulated in Cadence Virtuoso.

3.2 Task 1a

3.3 Task 1b

3.4 Task 2

4 Results

4.1 Task 1

4.2 Task 2

5 Discussion

5.1 Inaccuracy in measurements

Task 1a:

Task 1b:

5.2 Assessment of values

Task 1a:

Task 2:

5.3 Comparing task 1 and task 2

6 Appendix

6.1 Calculations

References

- [1] Philipp Häfliger. (2024). *Microelectronics Essentials* (beta 0.10). Department of Informatics, University of Oslo.
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- [3] Neureuther, A.R. (2001). Lecture 24: CMOS Capacitance and Circuit Delay [PDF]. University of California, Berkeley. https://inst.eecs.berkeley.edu/~ee42/fa01/LectNotes/42_24.pdf